Notice of References Cited Application/Control No. 10/584,716 Examiner LEON-VIET Q. NGUYEN Applicant(s)/Patent Under Reexamination LIM ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,016,329 A	01-2000	Iwasaki, Motoya	375/340
*	В	US-6,363,107 B1	03-2002	Scott, Logan	375/150
*	C	US-2003/0072397 A1	04-2003	Kim et al.	375/347
*	D	US-6,693,983 B1	02-2004	Moher et al.	375/341
*	Е	US-2004/0081076 A1	04-2004	Goldstein et al.	370/208
*	F	US-2005/0100119 A1	05-2005	Husted et al.	375/346
*	G	US-2005/0111408 A1	05-2005	Skillermark et al.	370/331
*	Η	US-2006/0140298 A1	06-2006	Dowling, Eric M.	375/260
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.